



CED20P06/CEU20P06

Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0V, I_D = -250\mu A$	-60			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -48V, V_{GS} = 0V$			-1	μA
Gate Body Leakage Current, Forward	I_{GSSF}	$V_{GS} = 20V, V_{DS} = 0V$			100	nA
Gate Body Leakage Current, Reverse	I_{GSSR}	$V_{GS} = -20V, V_{DS} = 0V$			-100	nA
On Characteristics^b						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS} = V_{DS}, I_D = -250\mu A$	-1		-3	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = -10V, I_D = -4.5A$		92	105	$m\Omega$
		$V_{GS} = -4.5V, I_D = -3.9A$		120	150	$m\Omega$
Forward Transconductance	g_{FS}	$V_{DS} = -5V, I_D = -3A$		2		S
Dynamic Characteristics^c						
Input Capacitance	C_{iss}	$V_{DS} = -30V, V_{GS} = 0V,$ $f = 1.0\text{ MHz}$		720		pF
Output Capacitance	C_{oss}			180		pF
Reverse Transfer Capacitance	C_{rss}			60		pF
Switching Characteristics^c						
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -30V, I_D = -1A,$ $V_{GS} = -10V, R_{GEN} = 6\Omega$		11	45	ns
Turn-On Rise Time	t_r			9	30	ns
Turn-Off Delay Time	$t_{d(off)}$			46	150	ns
Turn-Off Fall Time	t_f			22	75	ns
Total Gate Charge	Q_g	$V_{DS} = -30V, I_D = -4.5A,$ $V_{GS} = -10V$		21	29	nC
Gate-Source Charge	Q_{gs}			3		nC
Gate-Drain Charge	Q_{gd}			6		nC
Drain-Source Diode Characteristics and Maximum Ratings						
Drain-Source Diode Forward Current	I_S				-13	A
Drain-Source Diode Forward Voltage ^b	V_{SD}	$V_{GS} = 0V, I_S = -4.5A$			-1.3	V
Notes : a.Repetitive Rating : Pulse width limited by maximum junction temperature. b.Pulse Test : Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$. c.Guaranteed by design, not subject to production testing.						

6

